

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/763,040 | Applicant(s)/Patent Under Reexamination LIPP, BRIAN A. | |
| | Examiner Annette F. Dixon | Art Unit 3771 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-5,311,875 A | 05-1994 | Stasz, Peter | 600/537 |
| * | B | US-5,394,866 A | 03-1995 | Ritson et al. | 128/200.14 |
| * | C | US-5,522,378 A | 06-1996 | Ritson et al. | 128/200.14 |
| * | D | US-5,813,397 A | 09-1998 | Goodman et al. | 128/200.14 |
| * | E | US-5,950,619 A | 09-1999 | van der Linden et al. | 128/200.16 |
| * | F | US-2002/0092519 A1 | 07-2002 | Davis, Colin C. | 128/200.14 |
| * | G | US-2004/0055595 A1 | 03-2004 | Noymer et al. | 128/200.14 |
| * | H | US-2004/0081587 A1 | 04-2004 | Melker et al. | 422/084 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.